

PTO/SB/08A (10-96) [MODIFIED]
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Substitute for Form 1449A/PTO				Complete If Known	
INFORMATION DISCLOSURE STATEMENT BY APPLICANT (use as many sheets as necessary)				Application Number	10/658,657
				Filing Date	September 9, 2003
				First Named Inventor	Jack W. Shirlin et al.
				Group Art Unit	3742
				Examiner Name	Leonid M. Pastovsky
Sheet	1	of	6	Attorney Docket Number	KLAI 0101 PUS

U.S. PATENT DOCUMENTS						
Examiner Initials	Cite No.	U.S. PATENT DOCUMENT		Name of Patentee or Applicant of Cited Document	Date of Publication of Cited Document MM-DD-YYYY	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		Number	Kind Code ³ (if known)			
LMP		3,700,754		Schmitt et al.	10/24/1972	
		3,953,643		Cheung et al.	04/27/1976	
		3,968,056		Bolon et al.	07/06/1976	
		3,988,647		Bolon et al.	10/26/1976	
		4,049,844		Bolon et al.	09/20/1977	
		4,088,801		Bolon et al.	05/09/1978	
		4,113,894		Koch, II	09/12/1978	
		4,187,340		Oishi et al.	02/05/1980	
		4,188,449		Lu et al.	02/12/1980	
		RE30,274		Bolon et al.	05/13/1980	
		4,256,591		Yamamoto et al.	03/17/1981	
		4,271,212		Stengle	06/02/1981	
		4,338,376		Kritzler	07/06/1982	
		4,391,858		Batzill	07/05/1983	
		RE31,411		Bolon et al.	10/11/1983	
		4,420,500		Nakatani et al.	12/13/1983	
		4,439,494		Olson	03/27/1984	
		4,455,205		Olson et al.	06/19/1984	
LMP		4,478,876		Chung	10/23/1984	
		4,479,860		Hayase et al.	10/30/1984	

FOREIGN PATENT DOCUMENTS									
Examiner Initials	Cite No.	Foreign Patent Document			Name of Patentee or Applicant of Cited Document	Date of Publication of Cited Document MM-DD-YYYY	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	T ⁴	
		Office *	Number *	Kind Code ³ (if known)					
LMP		GB	1 550 382		Rohm & Haas Co.	08/15/1979			
		EP	0 081 323 A1		Johnson Matthey PLC	06/15/1983			
		EP	0 530 141 A1		Ciba-Geigy AG	03/03/1993			
		EP	0 567 940 A1		Glunz AG	11/03/1993			
		EP	0 711 801 A2		Dow Corning Corp.	05/15/1996			
		WO	97/31051		Dymax Corporation	08/28/1997			
		WO	97/45458		UV Coatings Limited	12/04/1997			
		EP	0 820 217 A1		BI Du Pont De Nemours	01/21/1998			
LMP		WO	98/47954		DSM N.V.	10/29/1998			

Examiner Signature	<i>Leonid M. Pastovsky</i>	Date Considered	5/31/05
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		Filing Date	September 9, 2003
		First Named Inventor	Jack W. Shirlin et al.
		Group Art Unit	3742
		Examiner Name	Leonid M. Pastovsky
Sheet 2 of 6	Attorney Docket Number	KLAI 0101 PUS	

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		Number	Kind Code ² (if known)			
LHF		4,495,042		Hayase et al.	01/22/1985	
		4,496,475		Abrams	01/29/1985	
		4,513,023		Wary	04/23/1985	
		4,533,445		Orio	08/16/1985	
		4,539,258		Panush	09/03/1985	
		4,547,410		Panush et al.	10/15/1985	
		4,551,361		Burzynski et al.	11/05/1985	
		4,557,975		Moore	12/10/1985	
		4,594,315		Shibue et al.	06/10/1986	
		4,609,612		Berner et al.	09/02/1986	
		4,640,981		Dery et al.	02/03/1987	
		4,665,342		Topp et al.	05/12/1987	
		4,666,821		Hein et al.	05/19/1987	
		4,684,353		deSouza	08/04/1987	
		4,738,899		Bluestein et al.	04/19/1988	
		4,788,108		Saunders, Jr et al.	11/29/1988	
		4,806,257		Clark et al.	02/21/1989	
		4,814,208		Miyazaki et al.	03/21/1989	
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		4,822,646		Clark et al.	04/18/1989	
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		4,877,512		Bowns et al.	10/31/1989	

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Examiner Initials	Cite No.	Foreign Patent Document			Name of Patentee or Applicant of Cited Document	Date of Publication of Cited Document MM-DD-YYYY	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	Y ³
		Office ⁴	Number ⁴	Kind Code ⁴ (if known)				
LHF		WO	98/50317		DSM N.V.	11/12/1998		
		DE	198 35 917 A1		BASF AG	02/10/2000		
		WO	00/62586		Allied Photochemical	10/19/2000		
		JP	61203108A (Abstract)		Toyobo KK	09/09/1986		Y
		JP	6016721A (Abstract)		Nippon Kayaku KK	01/25/1994		Y
		JP	5311103A (Abstract)		Tanaka Kikinzoku	11/22/1993		Y
		JP	4267097A (Abstract)		Mitsui Toatsu Chem	09/22/1992		Y
LHF		JP	5279436A (Abstract)		Japan Synthetic Rubber Co.	10/26/1993		Y

Examiner Signature	<i>Leonid M. Pastovsky</i>	Date Considered	5/31/05
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<small>⁵ Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST. 16 if possible. ⁶ Applicant is to place a check mark here if English language Translation is attached.</small>			

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**INFORMATION DISCLOSURE
STATEMENT BY APPLICANT**

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Sheet

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of

6

Complete if Known

Application Number

10/658,657

Filing Date

September 9, 2003

First Named Inventor

Jack W. Shirlin et al.

Group Art Unit

3742

Examiner Name

Leonid M. Pastovsky

Attorney Docket Number

KLAI 0101 PUS

U.S. PATENT DOCUMENTS

U.S. PATENT DOCUMENTS						
Examiner Initials	Cite No. ¹	U.S. PATENT DOCUMENT		Name of Patentee or Applicant of Cited Document	Date of Publication of Cited Document MM-DD-YYYY	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		Number	Kind Code ² (if known)			
MF		4,900,763		Kraushaar	02/13/1990	
		4,911,796		Reed	03/27/1990	
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		4,964,948		Reed	10/23/1990	
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		5,076,963		Kameyama et al.	12/31/1991	
		5,100,848		Enomoto et al.	03/31/1992	
		5,104,929		Bilkadi	04/14/1992	
		5,116,639		Kolk et al.	05/26/1992	
		5,128,387		Shustack	07/07/1992	
		5,128,391		Shustack	07/07/1992	
MF		5,149,971		McBlaney et al.	09/22/1992	
		5,180,523		Durand et al.	01/19/1993	
		5,180,757		Lucey	01/19/1993	
		5,183,831		Bielat et al.	02/02/1993	
		5,221,560		Perkins et al.	06/22/1993	

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**Examiner
Signature**

Date Considered

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Substitute for Form 1449A/PTO INFORMATION DISCLOSURE STATEMENT BY APPLICANT <i>(use as many sheets as necessary)</i>				Complete If Known	
				Application Number	10/658,657
				Filing Date	September 9, 2003
				First Named Inventor	Jack W. Shirlin et al.
				Group Art Unit	3742
				Examiner Name	Leonid M. Pastovsky
				Attorney Docket Number	KLAI 0101 PUS
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U.S. PATENT DOCUMENTS						
Examiner Initials	Cite No.	U.S. PATENT DOCUMENT		Name of Patentee or Applicant of Cited Document	Date of Publication of Cited Document MM-DD-YYYY	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		Number	Kind Code ² (if known)			
LMT		5,225,170		Kolk et al.	07/06/1993	
		5,282,985		Zabinski et al.	02/01/1994	
		5,296,295		Perkins et al.	03/22/1994	
		5,326,636		Durand et al.	07/05/1994	
		5,356,545		Wayte	10/18/1994	
		5,384,160		Frazzitta	01/24/1995	
		5,395,876		Frentzel et al.	03/07/1995	
		5,424,182		Marginean, Sr. et al	06/13/1995	
		5,453,451		Sokol	09/26/1995	
		5,454,892		Kardon et al.	10/03/1995	
		5,462,701		Hagemeyer et al.	10/31/1995	
		5,470,643		Dorfman	11/28/1995	
		5,470,897		Meixner et al.	11/28/1995	
		5,514,214		Joel et al.	05/07/1996	
		5,523,143		Hagemeyer et al.	06/04/1996	
		5,556,527		Igarashi et al.	09/17/1996	
		5,561,730		Lochkovic et al.	10/01/1996	
	HMF		5,565,126		Kimura et al.	10/15/1996
		5,587,433		Boeckeler	12/24/1996	
		5,596,024		Horie et al.	01/21/1997	

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Examiner Signature	<i>L. J. J. J. J.</i>	Date Considered	5/3/05
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Substitute for Form 1448A/PTO INFORMATION DISCLOSURE STATEMENT BY APPLICANT <i>(use as many sheets as necessary)</i>				Complete if Known	
				Application Number	10/658,657
				Filing Date	September 9, 2003
				First Named Inventor	Jack W. Shirlin et al.
				Group Art Unit	3742
				Examiner Name	Leonid M. Pastovsky
				Attorney Docket Number	KLAI 0101 FUS
Sheet	5	of	6		

U.S. PATENT DOCUMENTS

U.S. PATENT DOCUMENT						
Examiner Initials	Cite No.	Number	Kind Code ² (if known)	Name of Patentee or Applicant of Cited Document	Date of Publication of Cited Document MM-DD-YYYY	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
LME		5,609,918		Yamaguchi et al.	03/11/1997	
		5,624,486		Schmid et al.	04/29/1997	
		5,633,037		Mayer	05/27/1997	
		5,686,792		Ensign, Jr.	11/11/1997	
		5,698,310		Nakamura et al.	12/16/1997	
		5,716,551		Unruh et al.	02/10/1998	
		5,718,950		Komatsu et al.	02/17/1998	
		5,747,115		Howell et al.	05/05/1998	
		5,750,186		Frazzitta	05/12/1998	
		5,773,487		Sokol	06/30/1998	
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		5,914,162		Bilkadi	06/22/1999	
		5,942,284		Hiskes et al.	08/24/1999	
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